Home | Login | Logout | Access Information | Alerts | Sitemap | Help

Welcome United States Patent and Trademark Office

☐ Advanced Search

BROWSE

SEARCH

IEEE XPLORE GUIDE

SUPPORT

	in All Fields
AND 🔽	in All Fields
AND ▼	in All Fields

OPTION 2 Enter keywords, phrases, or a Boolean expression

transition	delay	fault	and	top-off	stuck-	E
at fault						
						v



- » Note: You may use the search operators <and> or <or> without the start and end brackets <>.
- » Learn more about Field Codes, Search Examples, and Search Operators

» Publications

- Select publications
 - ✓ IEEE Periodicals
 - ☑ IEE Periodicals
 - ▼ IEEE Conference Proceedings
 - ✓ IEE Conference Proceedings
 - ▼ IEEE Standards
- » Other Resources (Available for Purchase)
 - ✓ IEEE Books
- » Select date range
 - C Search latest content update (01 Aug 2005)
 - From year All to Present
- » Display Format
 - Citation
- C Citation & Abstract
- » Organize results

Maximum	100	
Display	25	results per pag
Sort by	Relevanc	e 🔽
In	Descendi	ng 🔽 order

Help Contact Us Privacy & Security IEEE.org © Copyright 2005 IEEE - All Rights Reserved

Indexed by #Inspec